

Wire Wound Chip Common Mode Chokes ACT1210 Series

FEATURES

- High common mode impedance at high frequency effects excellent noise suppression performance.
- Operating temperature -55~+150°C (Including self temperature rise)
- High reliability -Reliability tests comply with AEC-Q200
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

APPLICATIONS

Common mode noise filtering for automotive CAN-BUS and signal line

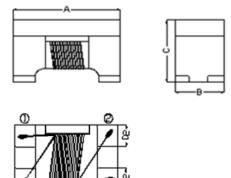
Explanation of Part Number

ACT 1210-101- 2P-T F

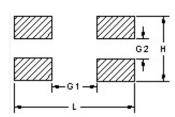
1 2 3 4 5 6

- ◆ 1:Product Series:Wire Wound Chip Common Mode Filters
- ♦ 2:Dimensions:
- ◆ 3:Inductance(µH):101=100uH
- ◆ 4:Number of Lines:2P=2 lines
- 5:Packing(Tape & Reel)
- ♦ 6:F:Hazardous Substance Free Products

Shapes and Dimensions [mm]

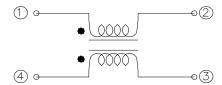


Recommended PC Board Pattern



Series	A(mm)	B(mm)	C(mm)	D1(mm)	D2(mm)	L(mm)	H(mm)	G1(mm)	G2(mm)
ACT1210	3.3±0.2	2.5±0.2	2.5 max	0.55±0.15	0.75±0.20	3.7	2.3	2.2	0.6

Schematic Diagram





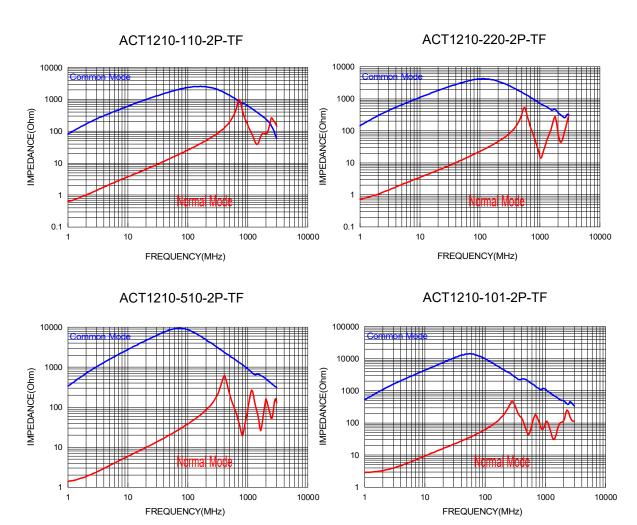




Electrical Characterisitics:

Part Number	Common mode Impedance (Ω) [10MHz]		Impedance (Ω) +50/-30% DC Resis		Rated Current (mA) max.		IR (M Ω) min.
ACT1210-110-2P-TF	300 min.	550 typ.	11	0.4	300	80	10
ACT1210-220-2P-TF	500 min.	1100 typ.	22	0.5	250	80	10
ACT1210-510-2P-TF	1000 min.	2600 typ.	51	0.7	200	80	10
ACT1210-101-2P-TF	2200 min.	5100 typ.	100	1.5	150	80	10

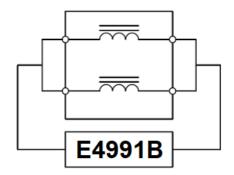
Typical Electrical Characteristics:



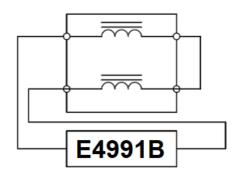


MEASURING CIRCUITS 2LINE

Common mode

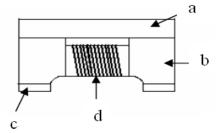


Differential mode



Materials

No.	Description	Specification
a.	Upper Plate	Ferrite
b.	Core	Ferrite Core
С	Termination	Ag/Ni/Sn
d	Wire	Enameled Copper Wire





Reliability Test

Item	Performance	Test Condition				
Operating temperature	-55~+150℃ (Including self - temperature rise)					
Storage temperature	-55~+150℃ (on board)					
Electrical Performance Tes	st					
Inductance		Keysight –E4980AL+ Keysight t -16334A				
DCR	Refer to standard electrical characteristics list.	Agilent-34420A Agilent-4338B				
I.R.		Chroma 19073				
Temperature Rise Test	Rated Current ∆T 40°C Max	Applied the allowed DC current. Temperature measured by digital surface thermometer.				
Reliability Test						
High Temperature Exposure(Storage) AEC-Q200 Temperature Cycling AEC-Q200		Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles Temperature: 150±2°C Duration: 1000hrs Min. Measured at room temperature after placing for 24±4 hrs Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles Condition for 1 cycle Step1: -55±2°C 30min Min. Step2: 150±2°C 30min Min. Step3: 150±2°C 30min Min. Step4: Low temp. Transition time 1min MAX. Number of cycles: 1000 Measured at room temperature after placing for 24±4 hrs				
Moisture Resistance (AEC-Q200)	Appearance: No damage Impedance: within±15% of initial value Inductance: within±10% of initial value RDC: within±15% of initial value and shall not exceed the specification value	t=24 hours/cycle. Note: Steps 7a & 7b Unpowered. The control of				
Biased Humidity (AEC-Q200)						
Operational Life (AEC-Q200)		Temperature: 150±2°C Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after placing for24±4hrs				
External Visual	Appearance: No damage.	Inspect device construction, marking and workmanship. Electrical Test not required.				
Physical Dimension	According to the product specification size measurement	According to the product specification size measurement				
Resistance to Solvents	Appearance : No damage.	Add aqueous wash chemical - OKEM clean or equivalent.				
Mechanical Shock	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value RDC: within ±15% of initial value and shall not exceed the specification	Type Peak value (g's) Normal duration (D) (ms) Wave form Velocity change (Vi)ft/sec SMD 100 6 Half-sine 12.3 Lead 100 6 Half-sine 12.3				
	value	3 shocks in each direction along 3 perpendicular axes. (18 shocks).				



Item	Performance	Test Condition				
Vibration		IPC/JEDEC J-STD-020E Classification Reflow Profiles Oscillation Frequency: 10Hz ~ 2KHz ~ 10Hz for 20 minute Equipment: Vibration checker Total Amplitude:5g Testing Time: 12 hours(20 minutes, 12 cycles each of 3 orientations) ~ Test condition:				
Resistance to Soldering Heat	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value RDC: within±15% of initial value and shall not exceed the	Temperature (°C) Time(s) Temperature ramp/immersion of heat cycles 260 ±5 10 ±1 25mm/s ±6 mm/s 1				
Thermal shock (AEC-Q200)	specification value	Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles Condition for 1 cycle Step1: -55±2°C 15±1min Step2: 150±2°C vithin 20Sec. Step3: 150±2°C 15±1min Number of cycles: 300 Measured at room temperature after placing fo24±4hrs				
ESD	Appearance:No damage.	Direct Contact and Air Discharge PASSIVE COMPONENT HBM ESD Discharge Waveform to a Coaxial Target Test method: AEC-Q200-002 Test mode: Contact Discharge Discharge level: 4 KV (Level: 2)				
Solderability	More than 95% of the terminal electrode should be covered with solder $^{\circ}$	a. Method B, 4 hrs @155°C dry heat @235°C±5°C Testing Time :5 +0/-0.5 seconds b. Method D category 3. (8hours ± 15 min)@ 260°C±5°C Testing Time :30 +0/-0.5 seconds				
Electrical Characterization	Refer Specification for Approval	Summary to show Min, Max, Mean and Standard deviation .				
Flammability	Electrical Test not required.	V-0 or V-1 are acceptable.				
Board Flex	Appearance : No damage	Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles Place the 100mm X 40mm board into a fixture similar to the one shown in below Figure with the component facing down. The apparatus shall consist of mechanical means to apply a force which will bend the board (D) x = 2 mm minimum. The duration of the applied forces shall be 60 (+ 5) sec. The force is to be applied only once to the board. Support Solder Chip Printed crout board before testing				
		Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a 17.7 N (1.8 Kg) force to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.				
Terminal Strength(SMD)	Appearance : No damage	radius 0,5 mm DUT wide thickness shear force				



Soldering

Mildly activated rosin fluxes are preferred. Metal-lions terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

1.1 IR Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

1.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Figure 2.)

- Preheat circuit and products to 150℃
- · Never contact the ceramic with the iron tip
- 350°C tip temperature (max)
- 1.0mm tip diameter (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- · Limit soldering time to 4~5sec.

Fig.1 IR Soldering Reflow

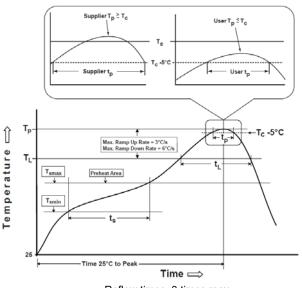
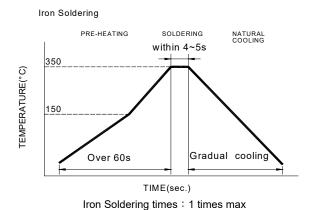


Fig.2 Iron soldering temperature profiles



Reflow times: 3 times max

Table (1.1): Reflow Profiles

Table (Tr): Notion 1 Tollies	
Profile Type:	Pb-Free Assembly
$\label{eq:continuous_series} \begin{split} & - \text{Temperature Min}(T_{\text{smin}}) \\ & - \text{Temperature Max}(T_{\text{smax}}) \\ & - \text{Time}(t_{\text{s}}) \text{from}(T_{\text{smin}} \text{ to } T_{\text{smax}}) \end{split}$	150°ℂ 200°ℂ 60-120seconds
Ramp-up rate(T_L to T_p)	3°C/second max.
Liquidus temperature(T_L) Time(t_L)maintained above T_L	217°C 60-150 seconds
Classification temperature(T _c)	See Table (1.2)
$Time(t_p)$ at Tc- $5^\circ\!\mathbb{C}$ (Tp should be equal to or less than Tc.)	< 30 seconds
Ramp-down rate(T _p to T _L)	6°C /second max.
Time 25℃ to peak temperature	8 minutes max.

Tp: maximum peak package body temperature, Tc: the classification temperature.

For user (customer) **Tp** should be equal to or less than **Tc**.

Table (1.2) Package Thickness/Volume and Classification Temperature (T_c)

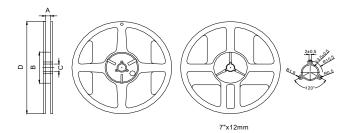
	Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
	<1.6mm	260°C	260°C	260°C
PB-Free Assembly	1.6-2.5mm	260°C	250°C	245°C
	≥2.5mm	250°C	245°C	245°C

Reflow is referred to standard IPC/JEDEC J-STD-020E •



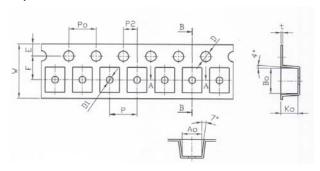
Packaging Information

Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60.0±2.0	13.5±0.5	178.0±2.0

Tape Dimension / 8mm

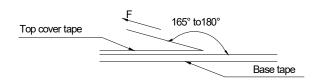


Serie	es	W(mm)	P(mm)	E(mm)	F(mm)	P2(mm)	D(mm)	D1(mm)	P0(mm)	A0(mm)	B0(mm)	K0(mm)	t(mm)
ACT121	0	8.00±0.10	4.00±0.10	1.75±0.10	3.50±0.05	2.00±0.05	1.50+0.10/-0.00	1.00±0.10	4.00±0.10	2.88±0.10	3.72±0.10	2.50±0.10	0.26±0.05

Packaging Quantity

Chip size	Chip/Reel	Inner Box	Middle Box	Carton
ACT1210	2000	10000	50000	100000

Tearing Off Force



The force for tearing off cover tape is 15 to 80 grams in the arrow direction under the following conditions.

Room Temp.	Room Temp. Room Humidity		Tearing Speed	
(℃)	(%)	(hPa)	mm/min	
5~35	45~85	860~1060	300	

Application Notice

- Storage Conditions(component level)
 - To maintain the solderability of terminal electrodes:
 - 1. Metal-lions products meet IPC/JEDEC J-STD-020E standard-MSL, level 1.

 - 3. Recommended products should be used within 12 months form the time of delivery.
 - 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
 - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.